Notice of References Cited Application/Control No. 10/777,026 Examiner Binh X. Tran Applicant(s)/Patent Under Reexamination KAWAGUCHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,204,203	03-2001	Narwankar et al.	438/785
	В	US-			
	ပ	US-			
	D	US-			
	ш	US-			
	F	US-			
	G	US-			
	H	US-			
ł	-	US-			
	J	US-			
	Κ	US			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
,	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.